

Physics of Electronics:

5. Semiconductors

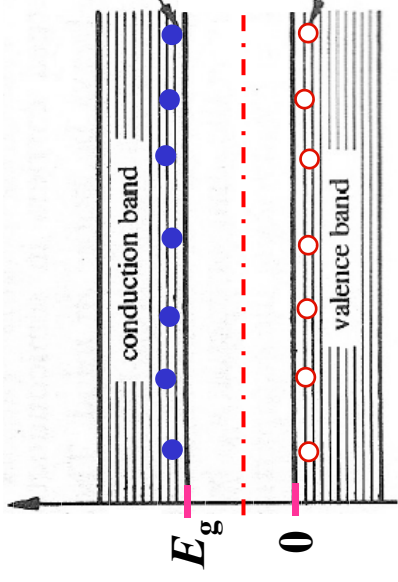
July – December 2009

Contents overview

- Density of carriers in intrinsic semiconductors.
- Density of carriers in extrinsic semiconductors.
- Compensation doping.
- Electrical conduction in semiconductors.
- Continuity equation.
- Semiconductor measurements.

Density of Carriers in Intrinsic sc

- Concentration of conduction electrons:

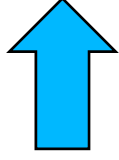


$$n = \int_{\text{conduction band}} S(E)P(E) dE = N_C \exp\left[-(E_g - E_F)/kT\right]$$

$$p = \int_{\text{valence band}} S_h(E)P_h(E) dE = N_V \exp\left[-E_F/kT\right]$$

$$np = n_i^2 = N_c N_v \exp(-E_g/kT)$$

$$n = p = n_i$$

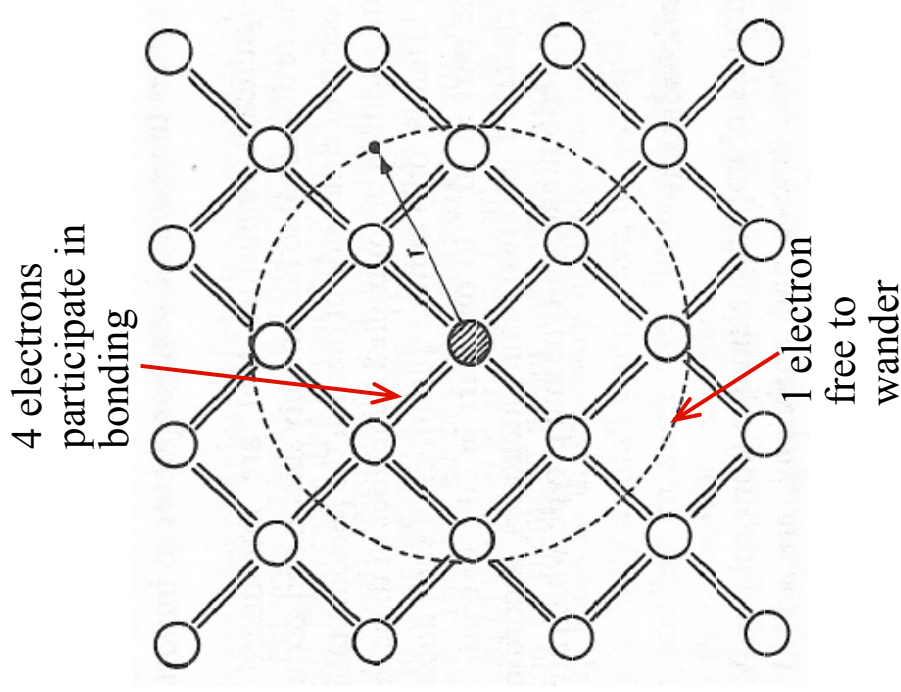


$$E_F = \frac{1}{2}E_g - \frac{3}{4}kT \log(m_e^*/m_h^*)$$

Extrinsic or Impurity SC

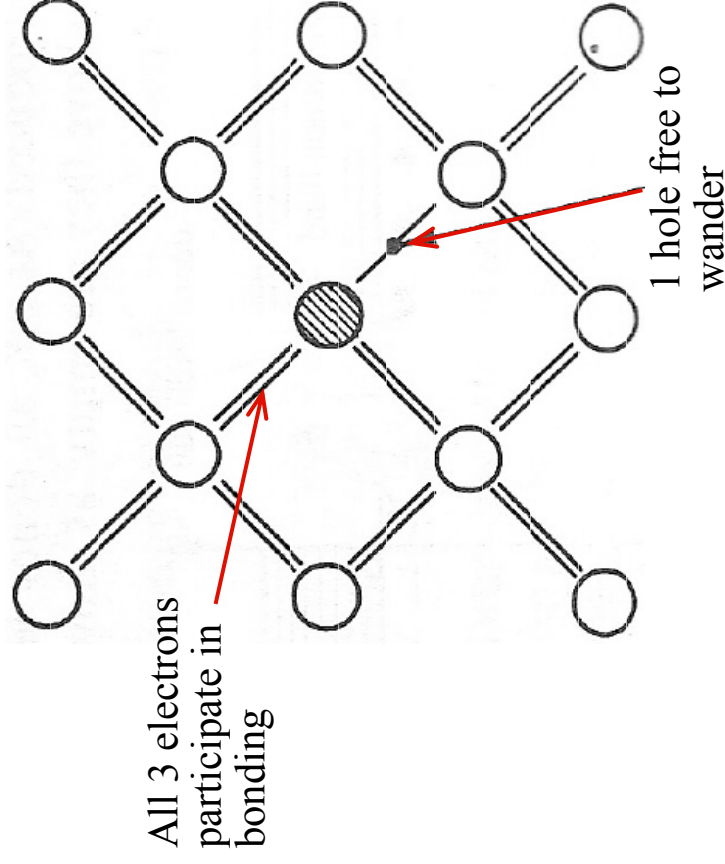
Donors

n-type semiconductors
(pentavalent impurities)



Acceptors

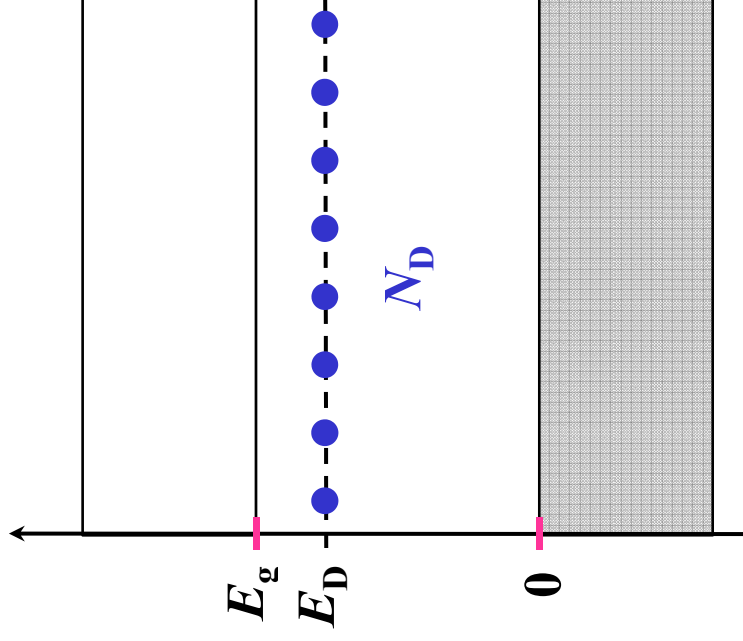
p-type semiconductors
(trivalent impurities)



Extrinsic or Impurity sc

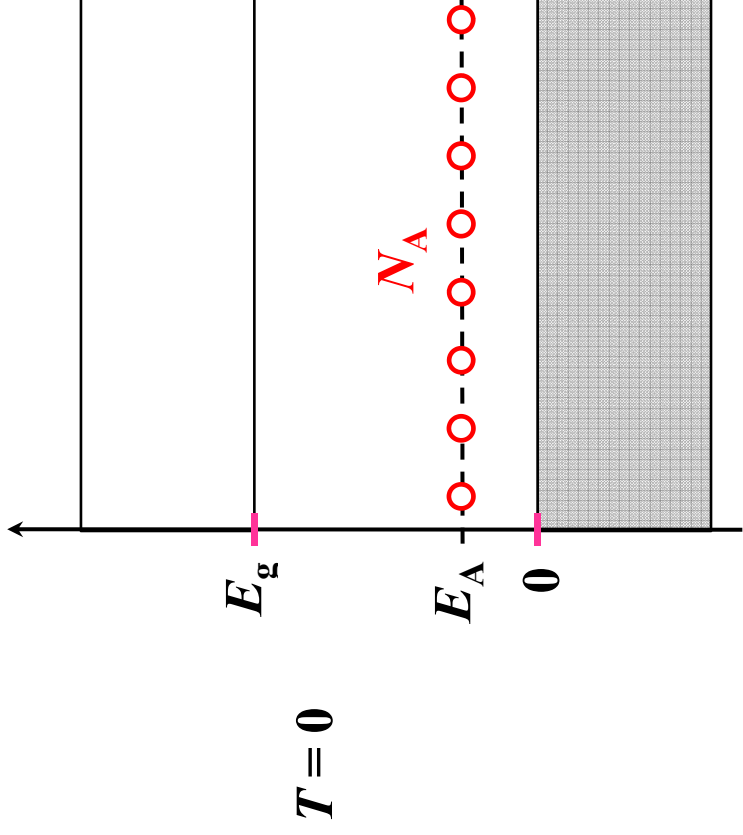
Donors

n-type semiconductors
(pentavalent impurities)



Acceptors

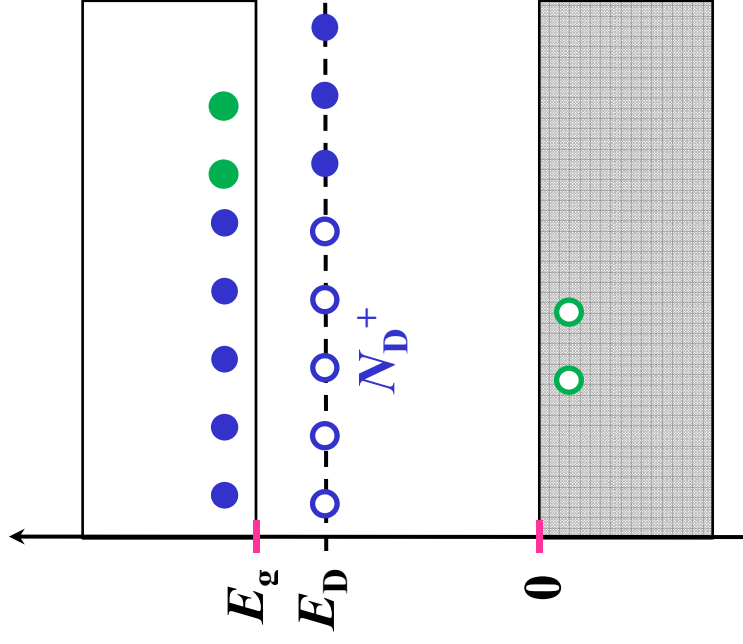
p-type semiconductors
(trivalent impurities)



Extrinsic or Impurity sc

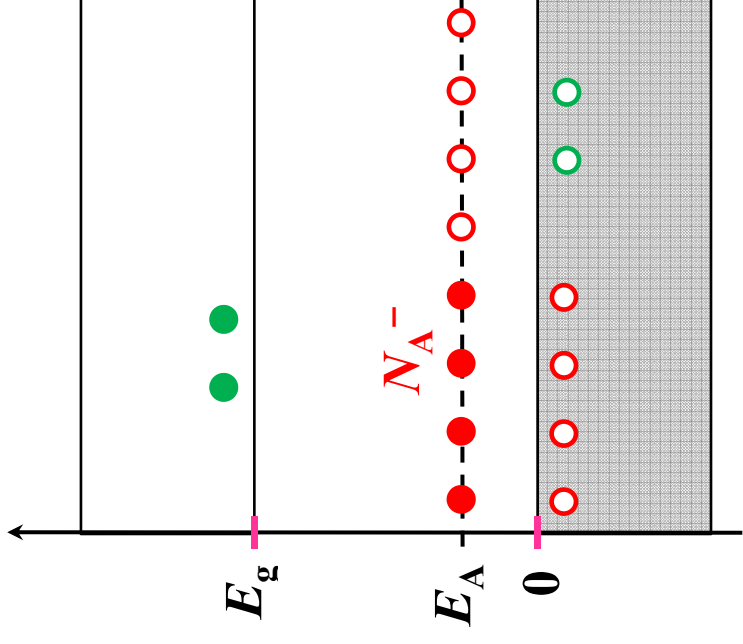
Donors

n-type semiconductors
(pentavalent impurities)



Acceptors

p-type semiconductors
(trivalent impurities)



Density of carriers in extrinsic sC

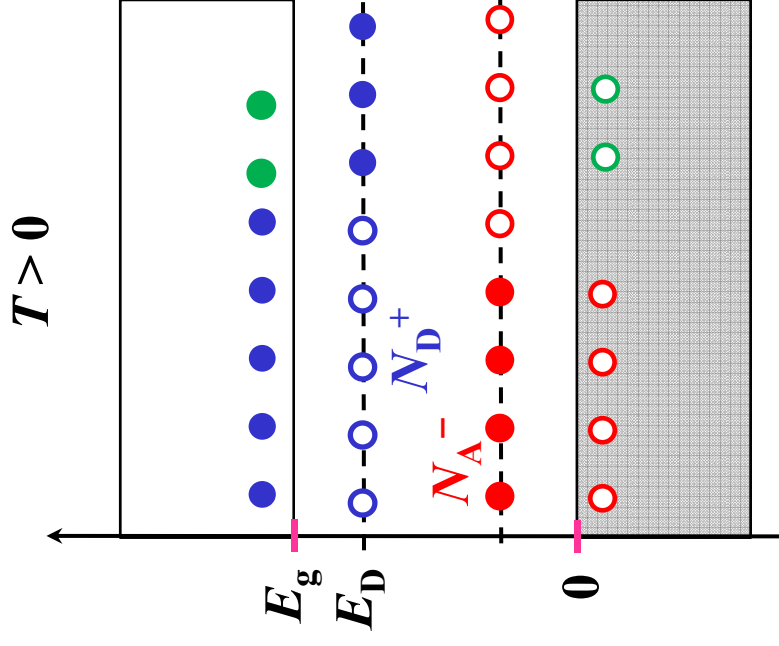
- Consider a sC with donors and acceptors.
- How does EF change?
 - Electrical neutrality

$$p + N_d^+ = n + N_a^-$$

$$n = N_C \exp\left[-(E_g - E_F)/kT\right] \quad p = N_V \exp\left[-E_F/kT\right]$$

$$N_a^- = \frac{N_a}{1 + \exp[(E_A - E_F)/kT]}$$

$$N_d^+ = N_d \left(1 - \frac{1}{1 + \exp[(E_D - E_F)/kT]}\right)$$



$$N_V \exp(-E_F/kT) + \frac{N_d}{1 + \exp[-(E_D - E_F)/kT]} = N_C \exp[-(E_g - E_F)/kT] + \frac{N_a}{1 + \exp[(E_A - E_F)/kT]}$$

Density of carriers in extrinsic sc

- Special cases (details left as homework)

- n-type material ($N_d \gg N_a$ & $n \gg p$)

$$\overset{0}{\cancel{p}} + N_d^+ = n + \overset{0}{\cancel{N_a^-}}$$

$$\exp(E_F/kT) = \frac{-1 + \{1 + (4N_d/N_c) \exp[(E_g - E_D)/kT]\}^{1/2}}{2 \exp(-E_D/kT)}$$

- T low ($\exp[(E_D - E_g)/kT] \gg 1$) OR N_d large ($N_d/N_c \gg 1$)

$$E_F = \frac{1}{2}(E_g + E_D) + \frac{1}{2}kT \log(N_d/N_c)$$



$$n = (N_d N_c)^{1/2} \exp[(E_D - E_g)/2kT] \propto N_d^{1/2}$$

- T high ($\exp[(E_D - E_g)/kT] \ll 1$) OR N_d low ($N_d/N_c \ll 1$)

$$E_F = E_g - kT \log(N_c/N_d)$$

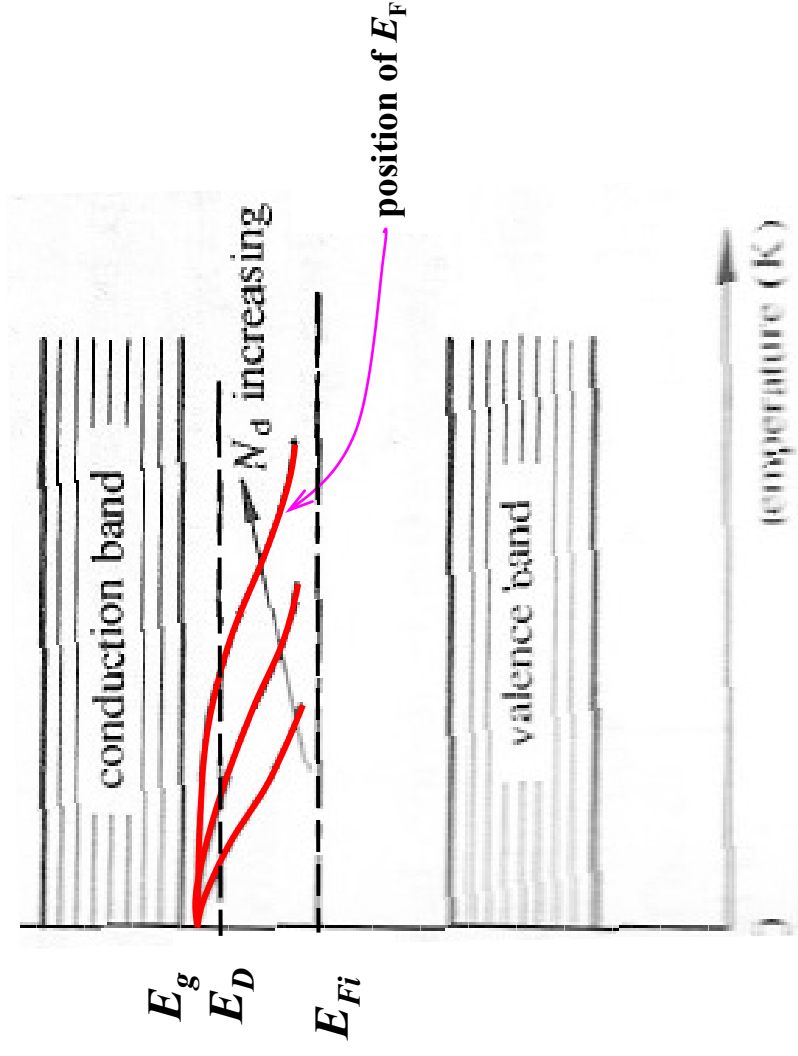


$$n = N_c \exp(-E_g/kT)(N_d/N_c) \exp(E_g/kT) = N_d$$

Density of carriers in extrinsic SC

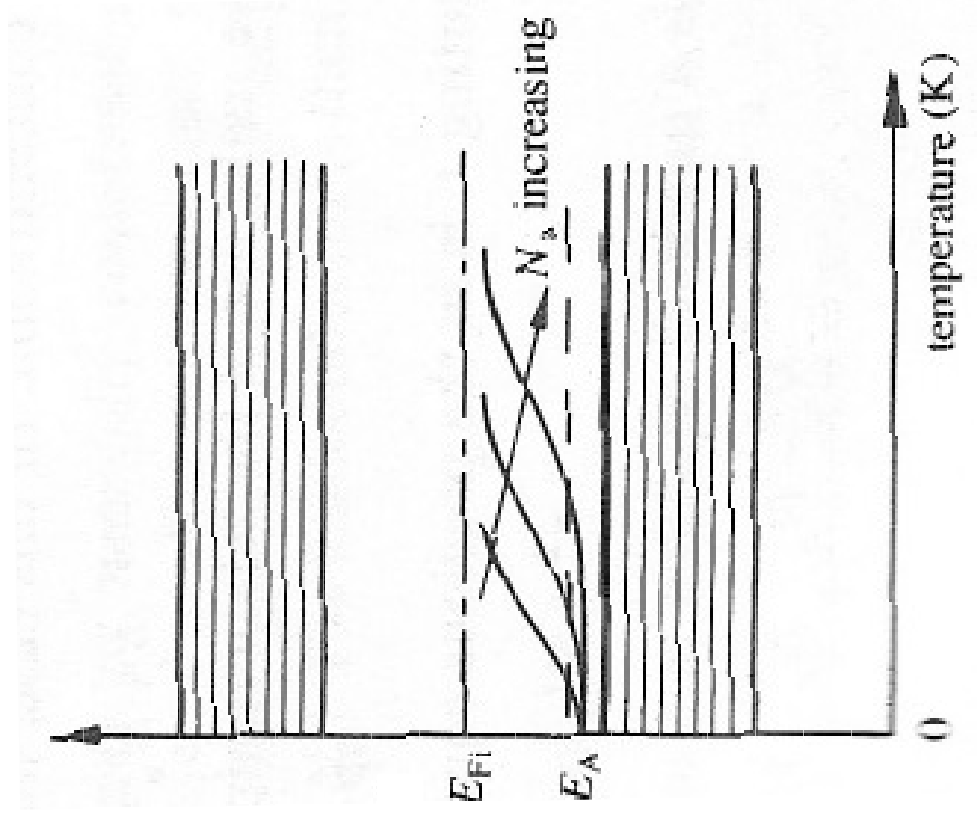
- Special cases (details left as homework)
 - n-type material ($N_d \gg N_a$ & $n \gg p$)

$$\overset{0}{p} + N_d^+ = n + \overset{0}{N_a^-}$$



Density of carriers in extrinsic SC

- Special cases (details left as homework)
 - p-type material ($N_a \gg N_d$ & $p \gg n$)



Compensation doping

- General considerations
 - Consider a sC with both donors and acceptors
 - Suppose all impurities are ionized ($N_a = N_a^+$ & $N_d = N_d^+$)
 - Electrical neutrality:

$$n + N_a = p + N_d \quad \xrightarrow{np = n_i^2} \quad n^2 - (N_d - N_a)n - n_i^2 = 0$$

$$\xrightarrow{\quad} n = \frac{N_d - N_a}{2} + \frac{N_d - N_a}{2} \left[1 + \left(\frac{2n_i}{N_d - N_a} \right)^2 \right]^{1/2}$$

- Idem:

$$p = -\frac{N_d - N_a}{2} + \frac{N_d - N_a}{2} \left[1 + \left(\frac{2n_i}{N_d - N_a} \right)^2 \right]^{1/2}$$

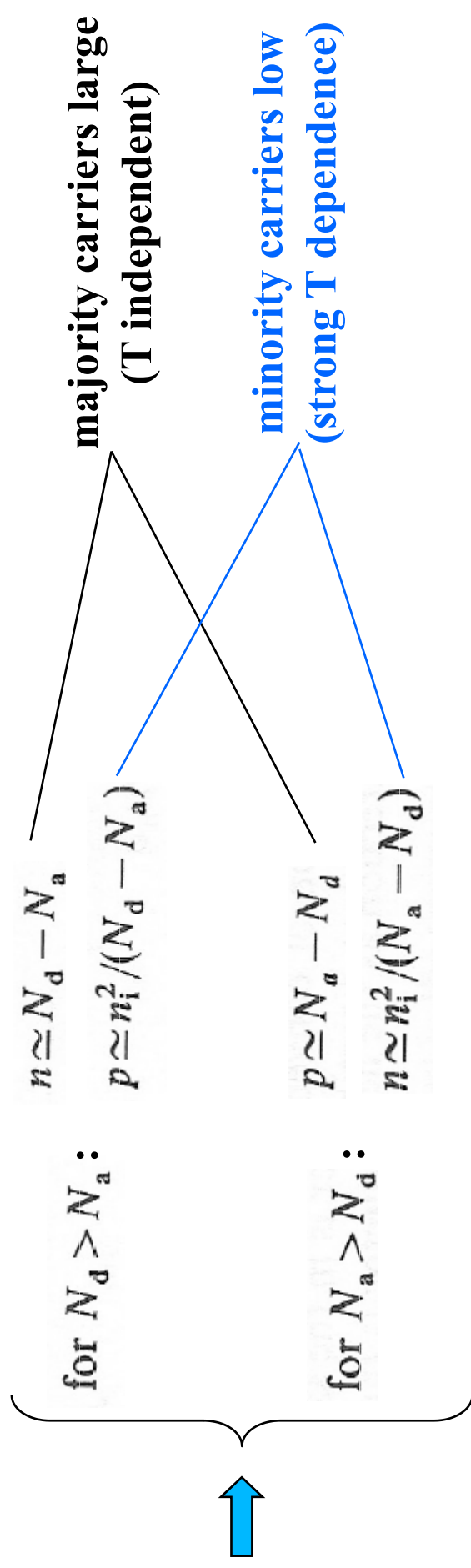
Compensation doping

$$n = \frac{N_d - N_a}{2} + \frac{N_d - N_a}{2} \left[1 + \left(\frac{2n_i}{N_d - N_a} \right)^2 \right]^{1/2}$$

$$p = -\frac{N_d - N_a}{2} + \frac{N_d - N_a}{2} \left[1 + \left(\frac{2n_i}{N_d - N_a} \right)^2 \right]^{1/2}$$

- Extrinsic compensated

- $n_i \ll |N_d - N_a|$:



Compensation doping

$$n = \frac{N_d - N_a}{2} + \frac{N_d - N_a}{2} \left[1 + \left(\frac{2n_i}{N_d - N_a} \right)^2 \right]^{1/2}$$

$$p = -\frac{N_d - N_a}{2} + \frac{N_d - N_a}{2} \left[1 + \left(\frac{2n_i}{N_d - N_a} \right)^2 \right]^{1/2}$$

- Intrinsic compensated

- $n_i \gg |N_d - N_a|$:

$$n = n_i + (N_d - N_a)/2$$

$$p = n_i + (N_d - N_a)/2$$

Conclusions

- Extrinsic sC are created by adding impurities:
 - Donors (extra electrons) and acceptors (extra holes).
- Concentration of majority and minority carriers was found